

2SK2529

Silicon N Channel MOS FET

Application

High speed power switching

Features

- Low on-resistance
 $R_{DS(on)} = 7 \text{ m}\Omega \text{ typ.}$
- High speed switching
- 4 V gate drive device can be driven from 5 V source

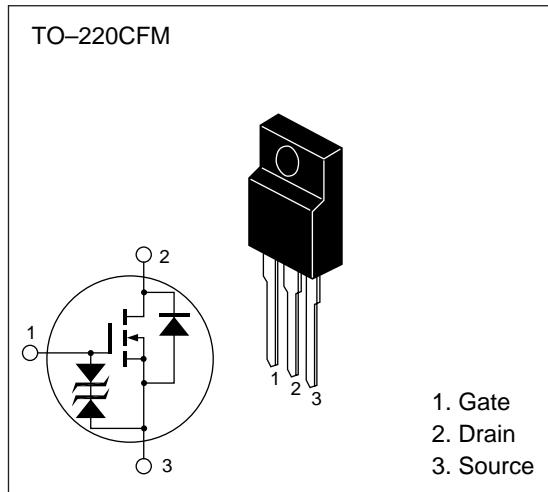


Table 1 Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	V_{DSS}	60	V
Gate to source voltage	V_{GSS}	± 20	V
Drain current	I_D	50	A
Drain peak current	$I_{D(\text{pulse})}^*$	200	A
Body-drain diode reverse drain current	I_{DR}	50	A
Avalanche current	I_{AP}^{***}	45	A
Avalanche energy	E_{AR}^{***}	174	mJ
Channel dissipation	P_{ch}^{**}	35	W
Channel temperature	T_{ch}	150	°C
Storage temperature	T_{stg}	-55 to +150	°C

* PW ≤ 10 µs, duty cycle ≤ 1 %

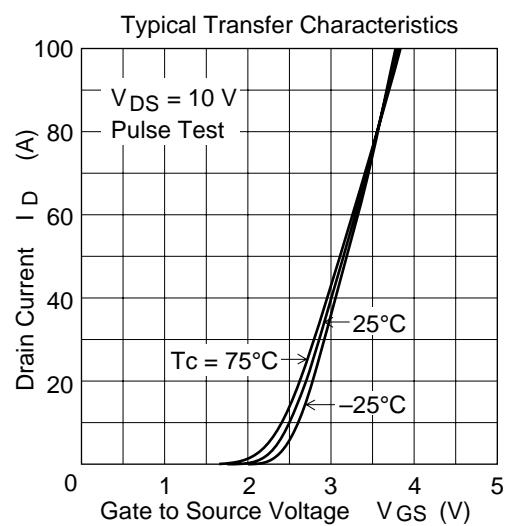
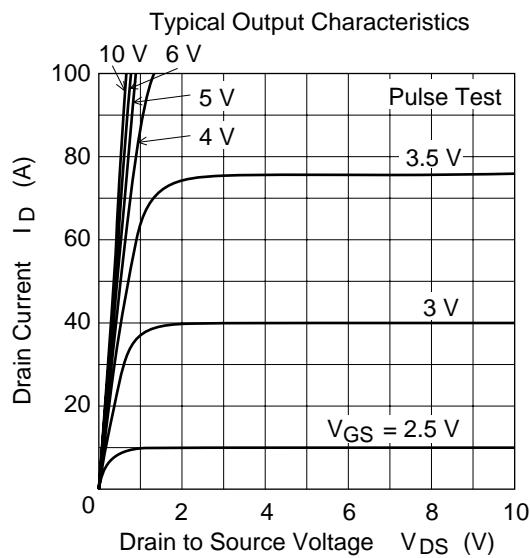
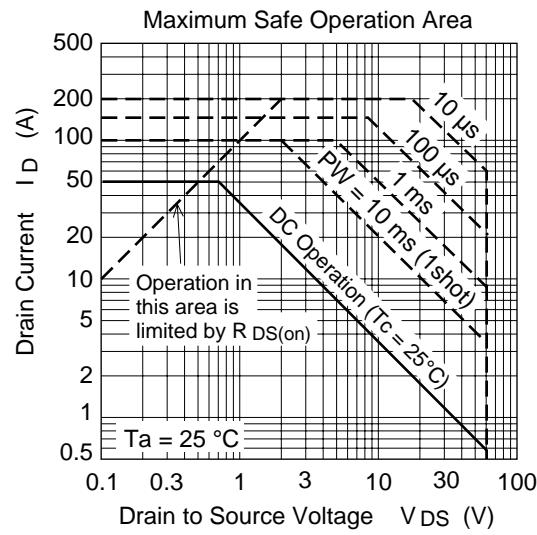
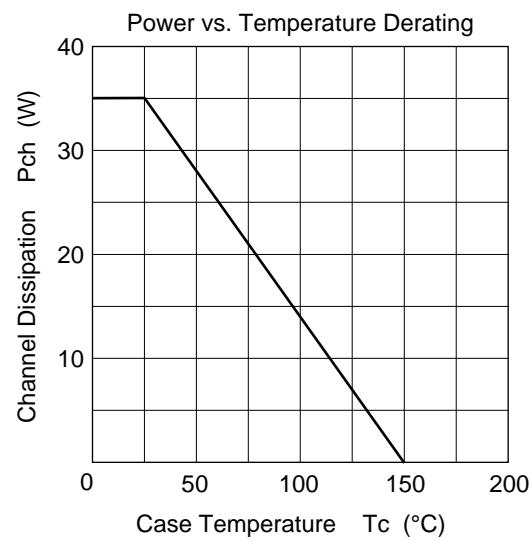
** Value at $T_c = 25^\circ\text{C}$

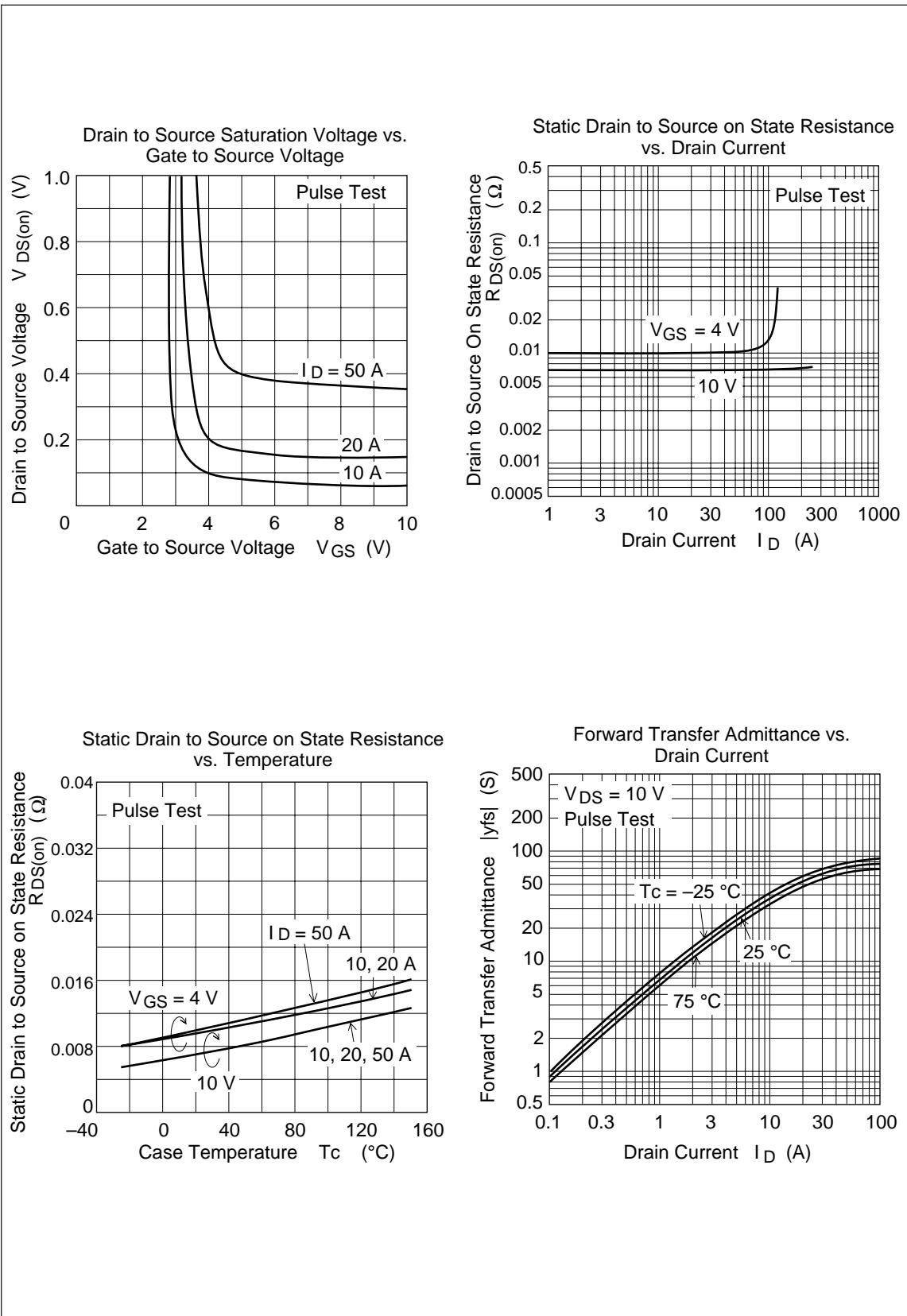
*** Value at $T_{ch} = 25^\circ\text{C}$, $R_g \geq 50 \Omega$

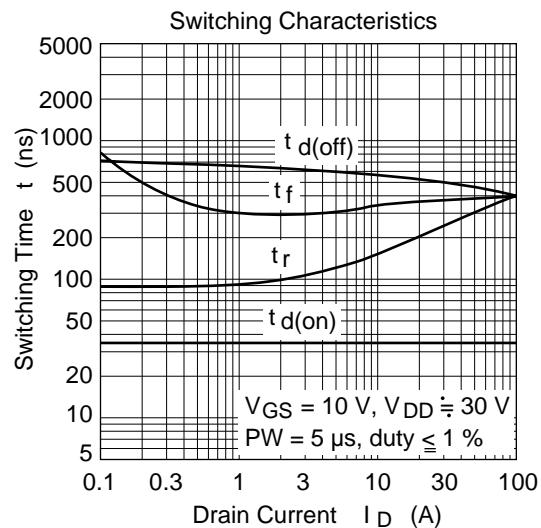
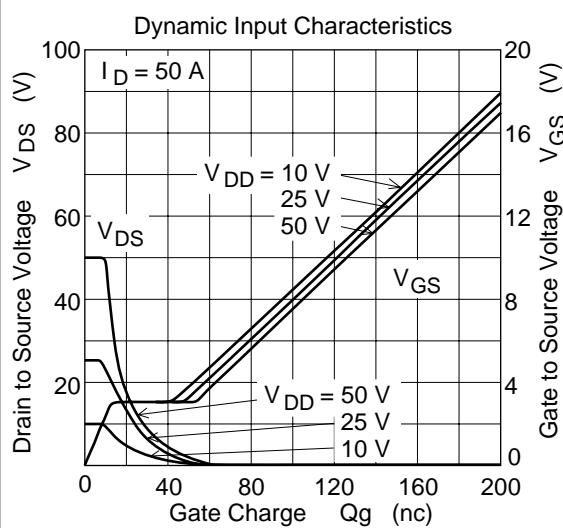
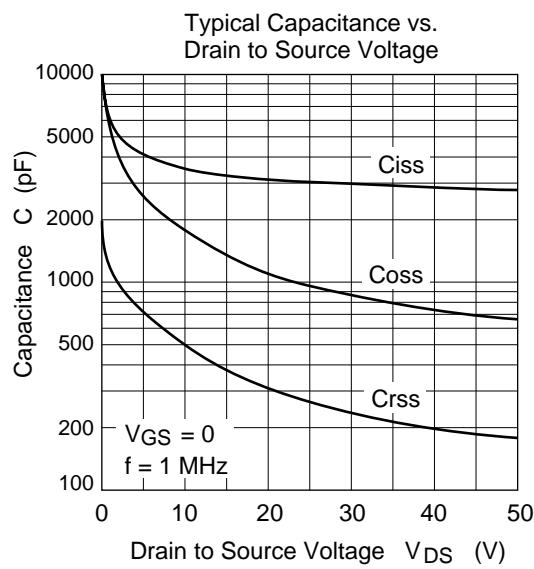
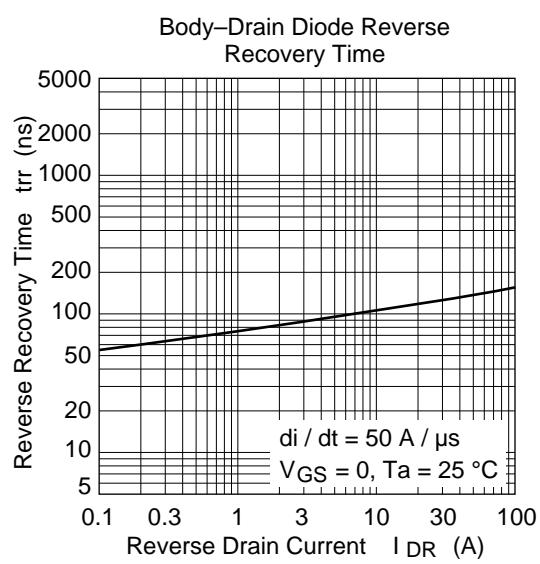
Table 2 Electrical Characteristics (Ta = 25°C)

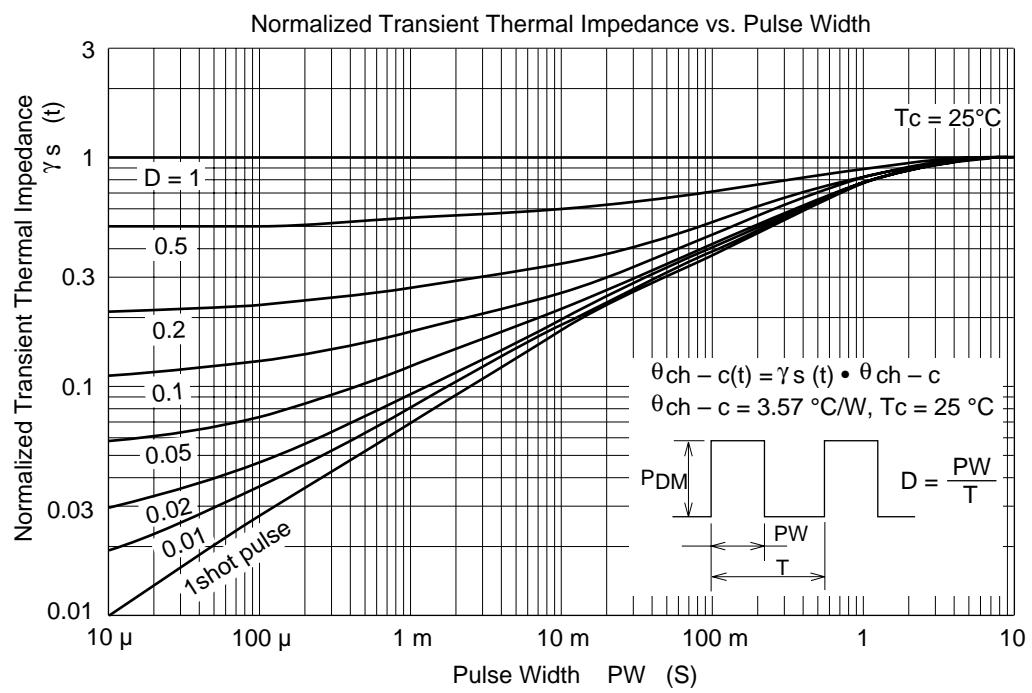
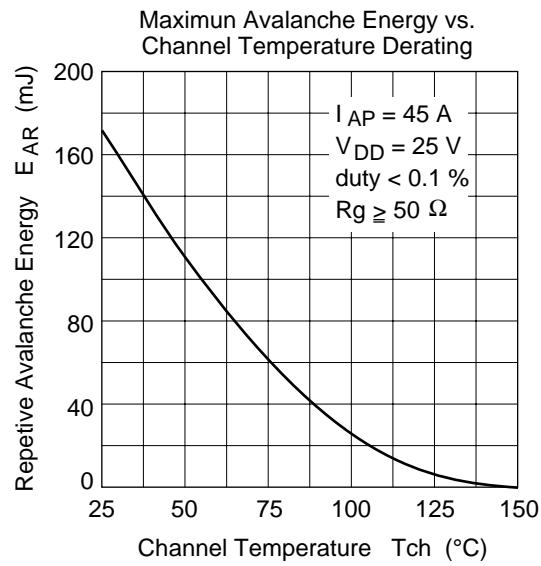
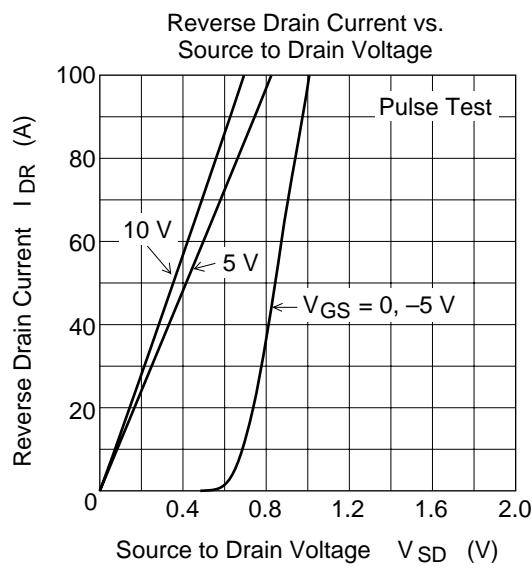
Item	Symbol	Min	Typ	Max	Unit	Test conditions
Drain to source breakdown voltage	V _{(BR)DSS}	60	—	—	V	I _D = 10 mA, V _{GS} = 0
Gate to source breakdown voltage	V _{(BR)GSS}	±20	—	—	V	I _G = ±100 µA, V _{DS} = 0
Gate to source leak current	I _{GSS}	—	—	±10	µA	V _{GS} = ±16 V, V _{DS} = 0
Zero gate voltage drain current	I _{DSS}	—	—	10	µA	V _{DS} = 60 V, V _{GS} = 0
Gate to source cutoff voltage	V _{GS(off)}	1.0	—	2.0	V	I _D = 1 mA, V _{DS} = 10 V
Static drain to source on state resistance	R _{DS(on)}	—	7	10	mΩ	I _D = 25 A V _{GS} = 10 V *
		—	10	16	mΩ	I _D = 25 A V _{GS} = 4 V *
Forward transfer admittance	y _{fs}	35	55	—	S	I _D = 25 A V _{DS} = 10 V *
Input capacitance	C _{iss}	—	3550	—	pF	V _{DS} = 10 V
Output capacitance	C _{oss}	—	1760	—	pF	V _{GS} = 0
Reverse transfer capacitance	C _{rss}	—	500	—	pF	f = 1 MHz
Turn-on delay time	t _{d(on)}	—	35	—	ns	I _D = 25 A
Rise time	t _r	—	230	—	ns	V _{GS} = 10 V
Turn-off delay time	t _{d(off)}	—	470	—	ns	R _L = 1.2 Ω
Fall time	t _f	—	360	—	ns	
Body-drain diode forward voltage	V _{DF}	—	0.85	—	V	I _F = 50 A, V _{GS} = 0
Body-drain diode reverse recovery time	t _{rr}	—	145	—	ns	I _F = 50 A, V _{GS} = 0 diF / dt = 50 A / µs

* Pulse Test

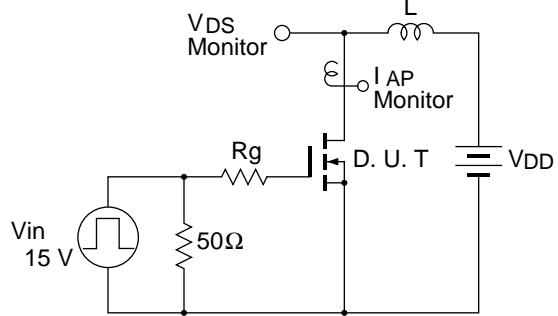




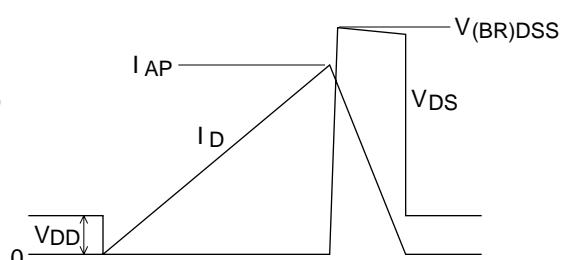




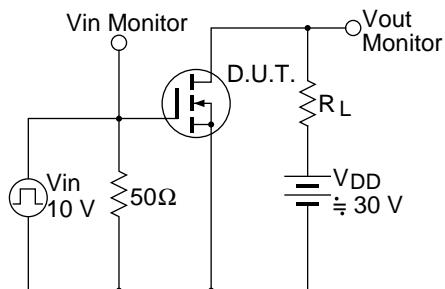
Avalanche Test Circuit and Waveform



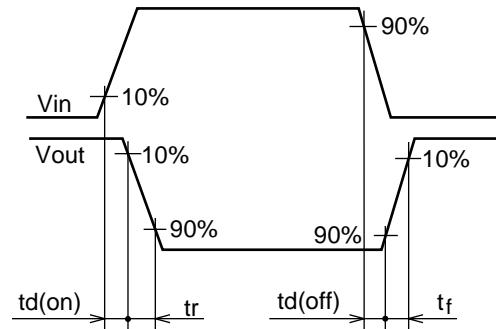
$$E_{AR} = \frac{1}{2} \cdot L \cdot I_{AP}^2 \cdot \frac{V_{DSS}}{V_{DSS} - V_{DD}}$$



Switching Time Test Circuit



Waveform



Package Dimensions

Unit : mm

